Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/787,314	BAYNE ET AL.	
Examiner	Art Unit	

2838

Pia F. Tibbits

SEARCHED					
Class	Subclass	Date	Examiner		
320	116	7/2/2006	pt		
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INTERFERENCE SEARCHED					
Class	Examiner				
320	PT				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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